

Timeway

- LABORATORIES

Report No: File reference No:	EMC	0504083 2005-06-02			
Applicant:	Gembird Electronics Ltd				
Product:	CPU and Audio Automatic Swi	tch			
Model No:	CAS-441				
Trademark:	Gembird				
Test Standards:	EN 55022:1998 +A1: 2000+A2: 2003 EN 55024:1998 +A1: 2001+A2: 2003	EN 61000-3-2:2000 EN 61000-3-3:1995 +A1: 2001			
Test result:		formed on the submitted samples with council EMC Directive			
Approved By					
Jack Chung					
EMC Manager					
Dated:	Jun 02, 2005				
Results appearing herein relate only to the sample tested The technical reports is issued errors and omissions exempt and is subject to withdrawal at					
HONG KONG TIMEWAY TECHNOLOGY DEVELOPMENT LIMITED					
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Test Report Conclusion



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1.0 General Details

- 1.1
 Test Lab Details

 Name :
 Hong Kong Timeway Technology Development Limited

 Address:
 Rm.1805,18/F., Wu Sang House, Nathan Road, Mongkok, Kln. HONG KONG

 Telephone:
 (852) 2781 7498

 Fax:
 (852) 2381 2492
- 1.2Applicant DetailsApplicant:Gembird Electronics LtdAddress:Room 1709, New Building, #2 Shennan ZhongLu, ShenzhenTelephone:86-755-82090225/82090379Fax:86-755-82090540
- 1.3 Description of EUT

 Product:
 CPU and Audio Automatic Switch

 Manufacturer:
 Gembird Electronics (Zhuhai) Co., Ltd.

 Brand Name:
 Gembird

 Model Number:
 CAS-441

 Additional Model Number:
 N/A

 Rating:
 DC5V 350mA 1.5W

 The Difference between models:-
- 1.4 Submitted Sample 1 Sample
- 1.5 Test Duration 2005-05-19 to 2005-06-02
- 1.6 Test Uncertainty

Conducted Emissions Uncertainty = ± 2.4 dB

- Radiated Emissions Uncertainty $= \pm 4.2$ dB
- 1.7 Test or witness Engineer

The sample tested by

Print Name: Ivy Zhu

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2.0 List of Measurement Equipment

2.1 Conducted Emission Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EMI Test Receiver	ESCS30	830245/009	RS	2005.2.23	1Year
Coaxial Switch	MP59B	M70585	ANRITSU	N/A	N/A
ISN	NTFM8132	8132137	SCHWARZBECK	2005.2.24	1Year
ISN	NTFM8134	8134109	SCHWARZBECK	2005.2.24	1Year
ISN	NTFM8136	8136102	SCHWARZBECK	2005.2.24	1Year

2.2 Radiated Disturbance Test Equipment

				Calibration	Calibration
Name	Model No	Serial No.	Manufacturer	Date	Cycle
EMI Test Receiver	ESCS30	830245/009	RS	2005.2.23	1Year
Coaxial Switch	MP59B	M70585	ANRITSU	N/A	N/A
Spectrum Analyzer(with	MS2661C	MT72089	ANRITSU	2005.2.23	
Tracking Generator)					1Year
Amplifier	MH648A	M20494	ANRITSU	2005.2.23	1Year
Bilog Antenna	CBL6101C	2576	CHASE	2005.2.23	1Year

2.3 Harmonic & Flicker Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Harmonics Flicker Test	5001ix-CTS				
System	-400	X71730	CI	2005.2.24	1Year

2.4 ESD Test Equipment

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
ESD Simulator	NSG435	2103	SCHNAFFNER	2005.2.23	1Year

2.5 Radiated electromagnetic disturbance test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EMI Test Receiver	ESCS30	830245/009	RS	2005.2.23	1Year
Coaxial Switch	MP59B	M70585	ANRITSU	N/A	N/A

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Spectrum Analyzer(with		Tryy a			
Tracking Generator)	MS2661C	MT72089	ANRITSU	2005.2.23	1Year
Amplifier	MH648A	M20494	ANRITSU	2005.2.24	1Year
Bilog Antenna	CBL6101C	2576	CHASE	2005.2.23	1Year

2.6 Electrical Fast Transient/Burst (EFT/B) immunity test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EFT Generator	NSG2025-1	2024	SCHNAFFNER	2005.2.23	1Year
Coupling Clamp	CDN126	418	SCHNAFFNER	N/A	N/A

2.7 Surge test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EMCPRO		9909302	KEYTEK	2005.2.23	1Year

2.8 Conducted Immunity test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
CW Generator	CW500	0399-10	EMTEST	2005.2.23	1Year
CDN	CDN-M2	9907105C	EMTEST	2005.2.23	1Year
CDN	CDN-M3	9905070C	EMTEST	2005.2.23	1Year
6dB Attenuator	ATT 6	9812105A	EMTEST	2005.2.23	1Year

2.9 Power Frequency magnetic field

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EMCPRO		9909302	KEYTEK	2005.2.23	1Year
Coil	F-1000-4-8/9/10-L-1M	9935	FCC	2005.2.23	1Year
Field Meter	ELF-66D	K71988-18	КЕҮТЕК	2005.2.23	1Year

2.10 Voltage Dips/Interruptions immunity test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EMCPRO		9909302	KEYTEK	2005.2.23	1Year

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3.0 Technical Details

3.1 Investigations Requested Perform Electromagnetic Interference [EMI] & Electromagnetic Suspectability[EMS] tests for CE Marking

3.2 Test Standards

Test Standards					
	Limits and methods of measurement of radio disturbance				
EN 55022:1998	characteristics of in	formation technology equipment			
LIN 33022.1998	Amendment A1:2000 t	to EN 55022:1998			
	Amendment A2:2003 t	to EN 55022:1998			
EN 61000-3-2:2000	Electromagnetic comp	patibility(EMC)- Part 3-2:Limits-Limits for harmonic			
EN 01000-3-2.2000	current emissions(equi	pment input current 16A per phase)			
	Electromagnetic comp	atibility (EMC)- Part 3-3:Limits-Limitation of voltage			
	changes, Voltage fluctuations and flicker in public low-voltage supply				
EN 61000-3-3:1995	systems. For equipment with rated current t 16A per phase and not				
	subject to conditional connection				
	Amendment A1:2001 to EN 61000-3-3:1995				
	Electromagnetic Cor	npatibility Generic Immunity Standard, Part 1:			
EN 55024:1998	Residential, Commerci	ial and Light Industry.			
LI(55024.1990	Amendment A1:2001 t	to EN 55024:1998			
	Amendment A2:2003 t	o EN 55024:1998			
	EN 61000-4-2:1995	Electrostatic discharge			
	EN 61000-4-3:1996	RF field strength susceptibility			
	EN 61000-4-4:1995	Electrical Fast transients			
	EN 61000-4-5:1995	Surge			
	EN 61000-4-6:1996	Conducted susceptibility			
	EN 61000-4-8:1994	Magnetic Field			
	EN 61000-4-11:1994	Dips/Voltage Interruption Variation			

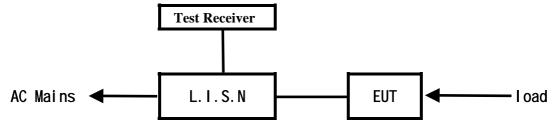
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4. **Power line Conducted Emission Test**

4.1 Schematics of the test

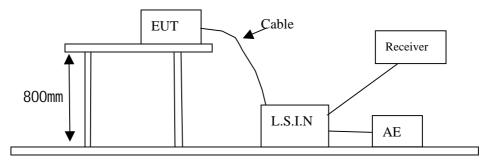


EUT: Equipment Under Test

4.2 Test Method:

The test was performed in accordance with EN 55022:1998

Block diagram of Test setup



4.3 Power line conducted Emission Limit

Frequency(MUz)	Limits dB(µ V)		
Frequency(MHz)	Quasi-peak Level	Average Level	
0.15 ~ 0.50	66.0 ~ 56.0*	56.0 ~ 46.0*	
0.50 ~ 5.00	56.0	46.0	
5.00 ~ 30.00	60.0	50.0	

Notes: 1. *decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies

4.4 Test Results

Limits for Conducted Emission test, Please refer to limit line (Quasi-peak) in the following diagram labelled as (QP)

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A Conducted Emission on Live Terminal of the power line (150kHz to 30MHz)

EUT set Condition: Normal Operation Mode

Results: N/A Please refer to following diagram for individual

Eroquopey	Readi ng(dB µ V)				Limit	
Frequency (MHz)	Li ve		Neutral		(dB µ V)	
	Quasi-peak	Average	Quasi-peak	Average	Quasi-peak	Average
			-	-		
			-	-		
			-	-		
			-	-		

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B Conducted Emission on Neutral Terminal of the power line (150kHz to 30MHz)

EUT set Condition: Normal Operation Mode

Results: N/A Please refer to following diagram for individual

Eroquonov		Readi ng	Limit			
Frequency (MHz)	Li ve		Neutral		(dB µ V)	
	Quasi-peak	Average	Quasi-peak	Average	Quasi-peak	Average
	-	-				
	-	-				
	-	-				
	-	-				

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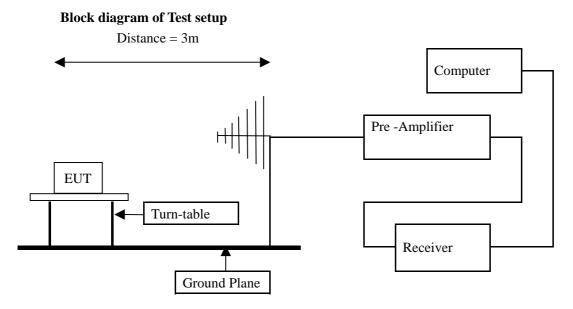
5 Radiated Disturbance Test

5.1 Schematics of the test



5.2 Test Method:

The test was performed in accordance with EN 55022:1998



5.3 Power line conducted Emission Limit

Frequency Range(MHz)	Peak limits (dB µ V/m)
30-230	40.0
230-1000	47.0

Note: The lower limit shall apply at the transition frequencies

5.4 Test result

Please refer to following table

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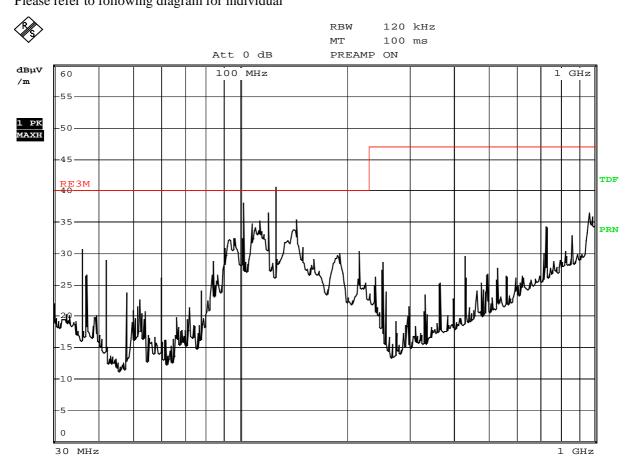
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Radiated Disturbance In Horizontal (30MHz----1000MHz)

EUT set Condition:

Normal Operation Mode

Results: Pass Please refer to following diagram for individual



Date: 1.JUN.2005 11:54:07

Frequency (MHz)	Level@3m (dB µ V/m)	Antenna Polarity	Limit@3m (dB µ V/m)
102.008	36.28	Н	40.00
113.632	34.50	Н	40.00
120.004	37.22	Н	40.00
126.012	38.27	Н	40.00

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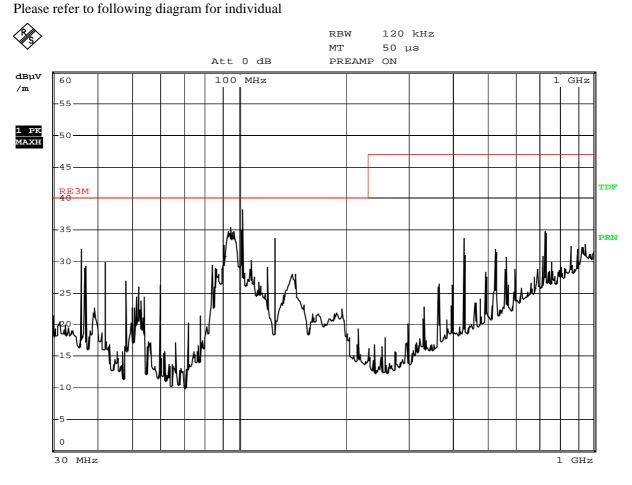
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Radiated Disturbance In Vertical (30MHz----1000MHz)

EUT set Condition:

Normal Operation Mode

Results: Pass



Date: 1.JUN.2005 12:08:59

Frequency (MHz)	Level@3m (dB µ V/m)	Antenna Polarity	Limit@3m (dB µ V/m)
94.884	35.19	V	40.00
102.008	38.14	V	40.00
26.012	34.29	V	40.00
432.106	33.20	V	47.00

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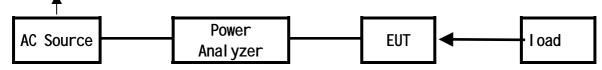
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6. <u>Voltage Fluctuations & Flicker Test</u>

6.1 Schematic of the test

AC Mains



EUT: Equipment Under Test

6.2 Test Method:

The test was performed in accordance with EN 61000-3-3:1995

6.3 Test Results

Result: N/A

* N/A --- The test is not applicable for the product because the power less than 70W. Please refer to the following pages

Maximum Occurring Levels:

Ut: 230.1	(EUT Test	RMS Vol	tage)
Pst:	Limit=	1.0	(The Highest short Term Flicker Value)
Plt:	Limit=	0.65	(The Highest Long Term Flicker Value)
dt(%):	Limit=	4%	(The Highest instantaneous Voltage Change (10ms))
dc(%):	Limit=	3%	(The highest Relative steady state voltage change (1sec))
dmax:	Limit=	4%	(The highest Max Relative voltage change)
Tdt:	Limit=	200ms	(The Max Time(in milli-sec) that dt exceeds 3%)

The report refers only to the sample tested and does not apply to the bulk.

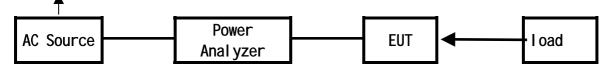
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7.0 <u>Harmonic Current Emission Test</u>

7.1 Schematic of the test

AC Mains



EUT: Equipment Under Test

7.2 Test Method

The test was performed in accordance with EN 61000-3-2: 2000

*: The Level of the product is : CLASS B

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7.3 **Test Results**

> * N/A --- The test is not applicable for the product because the power less than 70W. Please refer to the following pages Rating: --

No	(Test	No	(Test	No	(Test	No	(Test
	result/Limit)%		result/Limit)%		result/Limit)%		result/Limit)%
1	-	10	-	21	-	31	-
2	-	12	-	22	-	32	-
3	-	13	-	23	-	33	-
4	-	14	-	24	-	34	-
5	-	15	-	25	-	35	-
6	-	16	-	25	-	36	-
7	-	17	-	27	-	37	-
8	-	18	-	28	-	38	-
9	-	19	-	29	-	39	-
10	-	20	_	30	-	40	-

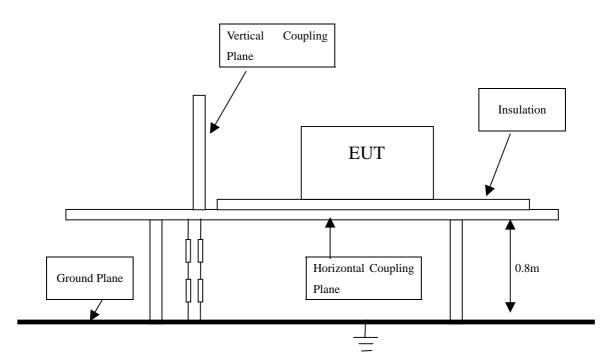
Harmonic results as a% of the limits

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8.0 Electrostatic Discharge

8.1 Schematic of the test



8.2 Test method

The test was performed in accordance with EN 61000-4-2:1995

8.3 Test severity

± 4kV for direct & in-direct Contact Discharge ± 8kV for air Discharge

Performance Criterion Require: B (Please see following table)

8.4 Susceptibility performance Criteria and Severity level

А	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
C	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
	damage of equipment(components) or software, or loss of data

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Severity Level	No. of the second secon	
Level	Test Voltage Direct & in-direct contact	Test Voltage Air
	Discharge (kV)	discharge(kV)
1	$\pm 2kV$	±2kV
2	$\pm 4 \mathrm{kV}$	$\pm 4 kV$
3	± 6kV	± 8kV
4	± 8kV	± 15kV

Test Result 8.5

Please refer to the following table for individual results.

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	*		
Location	Discharge Method	Test Voltage	Results
HCP (Horizontal coupling plane)	Contact Discharge	$\pm 4kV$	PASS
VCP(Vertical Coupling plane)	Contact Discharge	$\pm 4 kV$	PASS
Cover	Contact Discharge	$\pm 4kV$	PASS
PC1 Signal Terminals	Contact Discharge	$\pm 4 kV$	PASS
Mouse Terminals	Contact Discharge	$\pm 4 kV$	PASS
Keyboard Terminals	Contact Discharge	±4kV	PASS
USB	Contact Discharge	±4kV	PASS
PC2 all the terminals	Contact Discharge	±4kV	PASS
PC3 all the terminals	Contact Discharge	±4kV	PASS
PC4 all the terminals	Contact Discharge	±4kV	PASS
Console Mouse terminals	Contact Discharge	±4kV	PASS
Switch	Contact Discharge	±4kV	PASS
Location	Discharge Method	Test Voltage	Results
HCP (Horizontal coupling plane)	Air Discharge	± 8kV	PASS
VCP(Vertical Coupling plane)	Air Discharge	± 8kV	PASS
Cover	Air Discharge	± 8kV	PASS
PC1 Signal Terminals	Air Discharge	± 8kV	PASS
Mouse Terminals	Air Discharge	± 8kV	PASS
Keyboard Terminals	Air Discharge	± 8kV	PASS
USB	Air Discharge	± 8kV	PASS
PC2 all the terminals	Air Discharge	± 8kV	PASS
PC3 all the terminals	Air Discharge	± 8kV	PASS
PC4 all the terminals	Air Discharge	± 8kV	PASS
Console Mouse terminals	Air Discharge	± 8kV	PASS
Switch	Air Discharge	± 8kV	PASS
Remark: Calculated measurement u	ncertainty= ± 0.2 kV		

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9.0 RF field strength susceptibility (80MHz----- 1000MHz)

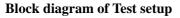
9.1 Schematics of the test

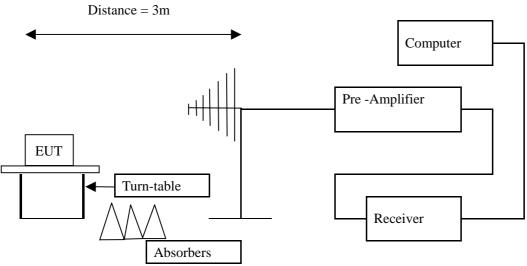


9.2 Test Method:

The test was performed in accordance with EN 61000-4-3:1996Severity:Level 2 (3V/m)Modulation:80% AM

Performance Criterion Require: A (Please see following table)





9.3 Susceptibility performance Criteria and severity Level

Susceptibility performance Criteria

А	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
	damage of equipment(components) or software, or loss of data

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Severity Level

Level	Field Strength (V/m)
1	1
2	3
3	10

9.4 Test Result:

Please refer to the following table for individual results.

Frequency (MHz)	Face	Polarity	Level (V/m)	Dwell Time(s)	Sweep Rate (%)	Results
80-1000	0 °	Horizontal	3	1	1	Pass
80-1000	90 °	Horizontal	3	1	1	Pass
80-1000	180 °	Horizontal	3	1	1	Pass
80-1000	270 °	Horizontal	3	1	1	Pass
80-1000	0 °	Vertical	3	1	1	Pass
80-1000	90 °	Vertical	3	1	1	Pass
80-1000	180 °	Vertical	3	1	1	Pass
80-1000	270 °	Vertical	3	1	1	Pass

Remark: Calculated measurement uncertainty= 80MHz to 1000mHz (+3.7/-1.3) V/m

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10.0 Electrical Fast Transient/Burst (EFT/B) immunity test

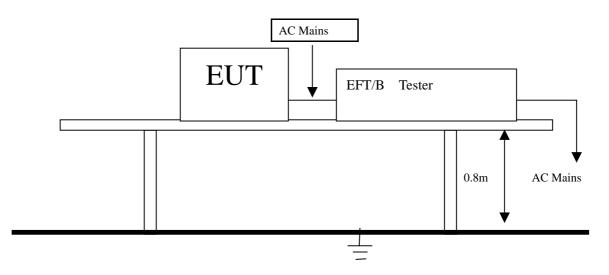
10.1 Schematics of the test



10.2 Test Method:

The test was performed in accordance with EN 61000-4-4:1995Severity:Level 2 (1kV)

Performance Criterion Require: B (Please see following table) Block diagram of Test setup



10.3 Susceptibility performance Criteria and Severity Level Susceptibility performance Criteria

А	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
	damage of equipment(components) or software, or loss of data

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Severity Level

Open Circuit output Test Voltag	ge ± 10%
On power Supply Lines	On I/O (Input/output)
	Signal data and control lines
0.5kV	0.5kV
1kV	1kV
2kV	2kV
4kV	4kV
Special	Special
	On power Supply Lines 0.5kV 1kV 2kV 4kV

10.4 Test Results

Please refer to following page.

Inject location:

Inject Line	Voltage	Inject	Method	Results
	kV	Times (s)		
L	±1	120S	Direct	Pass
Ν	±1	120S	Direct	Pass
L-N	± 1	120S	Direct	Pass

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11.0 Surge test

11.1 Schematics of the test

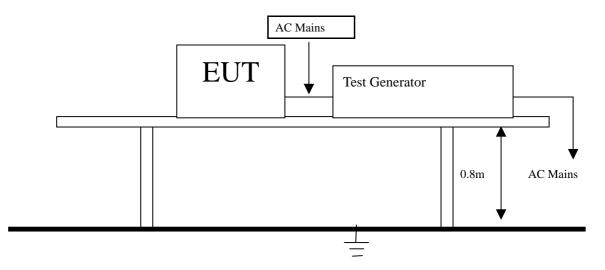


11.2 Test Method:

The test was performed in accordance with EN 61000-4-5:1995Severity:Level 2 (Line to Neutral at 1kV)

Performance Criterion Require: C (Please see following table)

Block diagram of Test setup



11.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is self recoverable
	sell recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
	damage of equipment(components) or software, or loss of data

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S	everity Level	No.
	Severity Level	Open-Circuit Test Voltage
		kV
	1	0.5
	2	1.0
	3	2.0
	4	4.0
ſ	*	Special

11.4 Test Results

Please refer to following page.

Test location:

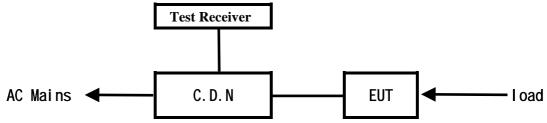
Location	Polarity	Phase	No of	Pulse	Results
		Angle	Pulse	Voltage(kV)	
L-N	+	0	5	1.0	Pass
	+	90	5	1.0	Pass
	+	180	5	1.0	Pass
	+	270	5	1.0	Pass
	-	0	5	1.0	Pass
	-	90	5	1.0	Pass
	-	180	5	1.0	Pass
	-	270	5	1.0	Pass

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12.0 Conducted Immunity test

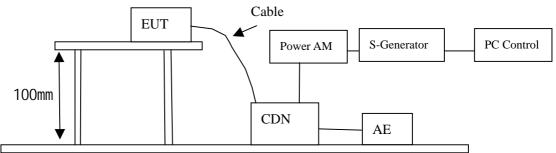
12.1 Schematics of the test



12.2 Test Method

The test was performed in accordance with EN 61000-4-6:1996Severity:Level 2(3 V rms),0.15MHz—80MHzPerformance Criterion Require:A (Please see following table)

Block diagram of Test setup



12.3 Susceptibility performance Criteria and Severity Level

A	Normal performance within the specification limits
A	Normal performance within the specification mints
В	Temporary degradation or loss of function or performance which is
	self recoverable
C	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
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Susceptibility performance Criteria

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Severity Level

Severity Level	Field Strength V/m
1	1
2	3
3	10
*	Special

12.4 Test Results:

Please refer to the following page

Γ	Frequency	Injected Position	Strength	Criterion	Result	
	Range (MHz)					
	0.15 - 20	AC Line	3V (rms)	٨	Pass	
			Unmodulated	А	Pass	
	20 - 80	AC Line	3V (rms)	Δ.	Pass	
			Unmodulated	А	1 488	

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13.0 Power Frequency magnetic field test

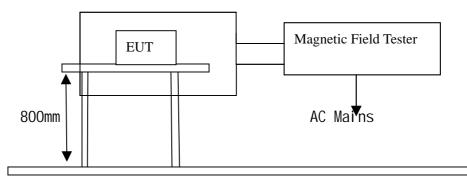
13.1 Schematics of the test



13.2 Test Method

The test was performed in accordance with EN 61000-4-8:1993Severity:Level 2 (3A/m),Performance Criterion Require:A (Please see following table)

Block diagram of Test setup



13.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

А	Normal performance within the specification limits		
В	Temporary degradation or loss of function or performance which is		
	self recoverable		
С	Temporary degradation or loss of function or performance w		
	requires operator intervention or system reset		
D	Degradation or loss of function which is not recoverable due to		
	damage of equipment(components) or software, or loss of data		

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Severity Level

Severity Level	Magnetic Field Strength A/m
1	1
2	3
3	10
4	30
5	100
*	Special

13.4 Test Results:

Please refer to the following page

Test Level	Testing Duration	Coil Orientation	Criterion	Result
3A/m	5 Mins	Horizontal	А	Pass
3A/m	5 Mins	Vertical	А	Pass

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14.0 Voltage Dips/Interruptions immunity test

14.1 Schematics of the test

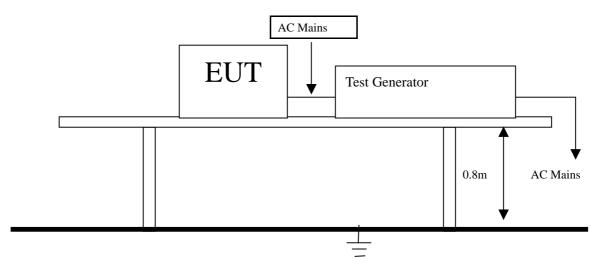


14.2 Test Method:

The test was performed in accordance with EN 61000-4-11:1994

Performance Criterion Require: C&B (Please see following table)

Block diagram of Test setup



14.3 Susceptibility performance Criteria and Severity Level Susceptibility performance Criteria

А	Normal performance within the specification limits		
В	Temporary degradation or loss of function or performance which is		
	self recoverable		
С	Temporary degradation or loss of function or performance with		
	requires operator intervention or system reset		
D	Degradation or loss of function which is not recoverable due to		
	damage of equipment(components) or software, or loss of data		

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S	everity Level		
	Test Level %Ut	Voltage dip and short interruptions %Ut	Duration(in period)
	0	100	0.5
			1
	40	60	5
			10
	70	30	25
			50
			*

14.4 Test Result:

Please refer to the following page

Test Level	Voltage	Duration(in	Phase Angle	Criterion	Result
% Ut	dips &short	period)			
	interruptions				
	% Ut				
0	100	250P	0°-360°	С	Pass
40	60	5P	0°-360°	С	Pass
70	30	0.5P	0°-360°	В	Pass

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- 15.0 Product Labeling
- 15.1 CE Mark label specification

Text of the mark is black or white in color and is left justified. Labels are printed in indelible ink on permanent adhesive backing and shall be affixed at a conspicuous location on the EUT or silk-screened onto the EUT.

CE

- 15.2 Mark Location: Rear enclosure
 - *

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Appendix:

Photos of the Product



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Appendix:

Photos of the Product



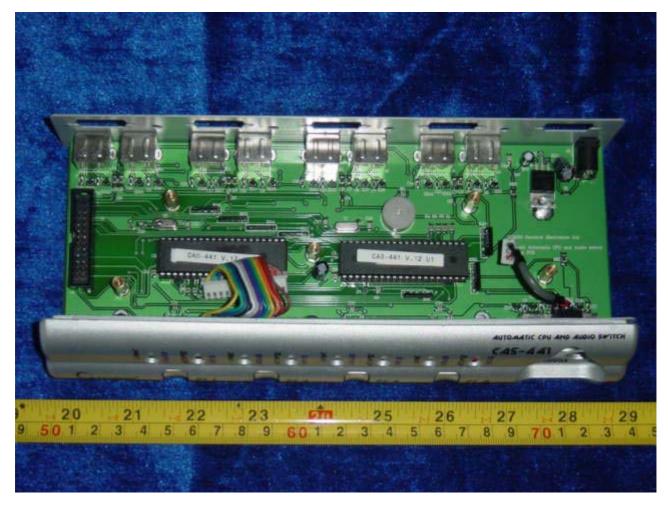
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Appendix:

Photos of the Product



End of the report

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